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Specialized Cutting Technique for QFN Leadframe Semiconductor Package

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Abstract—The paper presents a specialized cutting technique for package singulation without using the conventional mechanical blade

Keywords— Package singulation; cutting technique; QFN.

I. BACKGROUND OF THE STUDY

- Package singulation process is one of the known sawing techniques on QFN (quad flat no-lead) leadframe semiconductor manufacturing to separate the encapsulated leadframe into individual units
- Conventional package sawing or singulation process uses a mechanical blade to cut through the metal and mold material according to defined package size of the product

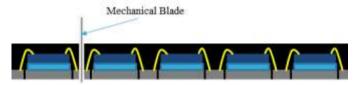


Fig. 1. Singulation of individual unit from the encapsulated leadframe strip.

 Conventional package singulation technique comes with some process/assembly related rejections:

- o Metal burrs
- o Un-cut
- o Shallow cut
- o Delamination due to singulation
- o Topside chippings
- Package chip-out was evident on Device Z with measurement greater than the specification limit of 125µm

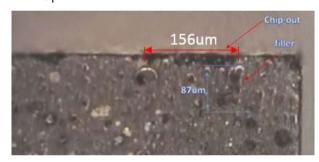


Fig. 2. Device Z topside chip-out.

 Parameter optimization, blade selection and evaluation, and ensuring planarity and calibration can help mitigate the package chip-out, but still cannot be totally eliminated due to the degradation of the mechanical blade

II. DESIGN SOLUTION

- A specialized cutting technique for QFN assembly is introduced without the use of mechanical blade to singulate or separate the unit individually
- The process is realized through modification of the mold tool design, maximizing the deflash process, and employing chemical etching process

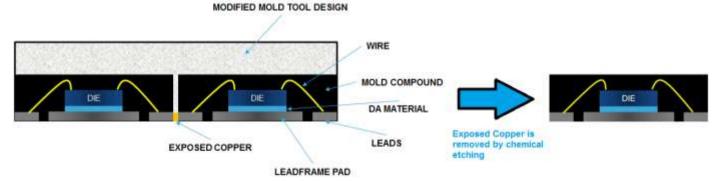


Fig. 3. Specialized cutting technique for QFN leadframe semiconductor package.

The specialized cutting technique is an advancement in QFN technology, supporting assembly yield improvement and cost